## Notice of References Cited Application/Control No. O9/614,371 Examiner Minh Dieu Nguyen Applicant(s)/Patent Under Reexamination LUTTRELL ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,330,672	12-2001	Shur, David Hilton	713/176
	В	US-6,226,387	05-2001	Tewfik et al.	382/100
	C	US-6,754,277	06-2004	Heinzelman et al.	375/240.27
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
		US-			
	J	US-			
	к	US-		-	
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q			-		
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		· Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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